

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC74AC299P, TC74AC299F

## 8-Bit PIPO Shift Register with Asynchronous Clear

The TC74AC299 is an advanced high speed CMOS 8-BIT PIPO SHIFT REGISTER fabricated with silicon gate and double-layer metal wiring C<sup>2</sup>MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

It has a four modes (HOLD, SHIFT LEFT, SHIFT RIGHT and LOAD DATA) controlled by the two selection inputs (S0, S1).

When one or both enable ( $\overline{G1}$ ,  $\overline{G2}$ ) are high, the eight I/O outputs are forced to the high-impedance state; however, sequential operation or clearing of the register is not affected.

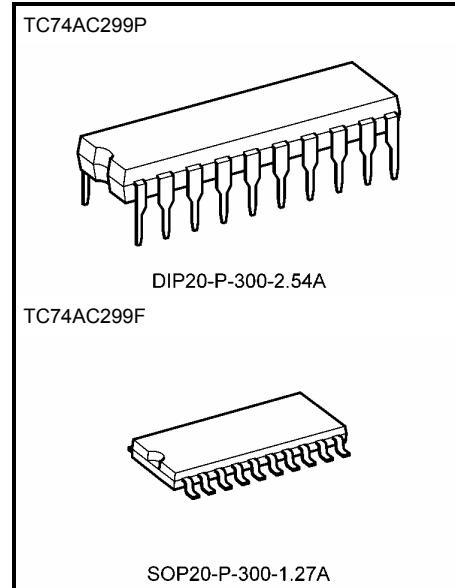
All inputs are equipped with protection circuits against static discharge or transient excess voltage.

### Features (Note 1)(Note 2)

- High speed:  $f_{max} = 150$  MHz (typ.) at  $V_{CC} = 5$  V
- Low power dissipation:  $I_{CC} = 8$   $\mu$ A (max) at  $T_a = 25^\circ$ C
- High noise immunity:  $V_{NIH} = V_{NIL} = 28\%$   $V_{CC}$  (min)
- Symmetrical output impedance:  $|I_{OH}| = I_{OL} = 24$  mA (min)  
Capability of driving 50  $\Omega$  transmission lines.
- Balanced propagation delays:  $t_{pLH} \approx t_{pHL}$
- Wide operating voltage range:  $V_{CC} (opr) = 2$  to 5.5 V
- Pin and function compatible with 74F299

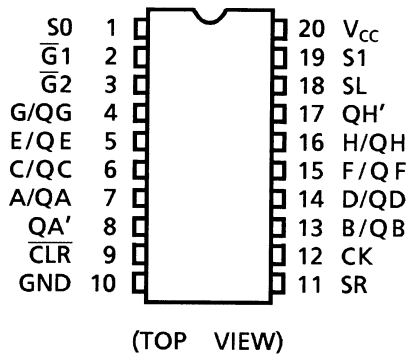
Note 1: Do not apply a signal to any bus terminal when it is in the output mode. Damage may result.

Note 2: All floating (high impedance) bus terminals must have their input levels fixed by means of pull up or pull down resistors.

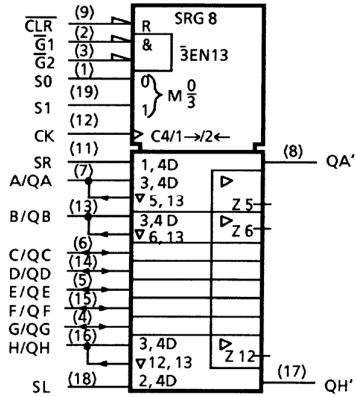


Weight	
DIP20-P-300-2.54A	: 1.30 g (typ.)
SOP20-P-300-1.27A	: 0.22 g (typ.)

### Pin Assignment



**IEC Logic Symbol**



**Truth Table**

Mode	Inputs								Inputs/ Outputs		Outputs	
	CLR	Function select		Outputs Control		CK	Serial		A/QA	H/QH	QA'	QH'
		S1	S0	G1 (Note)	G2 (Note)		SL	SR				
Clear	L	H	H	X	X	X	X	X	Z	Z	L	L
	L	L	X	L	L	X	X	X	L	L	L	L
	L	X	L	L	L	X	X	X	L	L	L	L
Hold	H	L	L	L	L	X	X	X	QA0	QH0	QA0	QH0
Shift Right	H	L	H	L	L	$\uparrow$	X	H	H	QGn	H	QGn
	H	L	H	L	L	$\uparrow$	X	L	L	QGn	L	QGn
Shift Left	H	H	L	L	L	$\uparrow$	H	X	QBn	H	QBn	H
	H	H	L	L	L	$\uparrow$	L	X	QBn	L	QBn	L
Load	H	H	H	X	X	$\uparrow$	X	X	a	h	a	h

Note: When one or both output controls are high, the eight input/output terminals are in the high-impedance state; however sequential or clearing of the register is not affected.

Z: High impedance

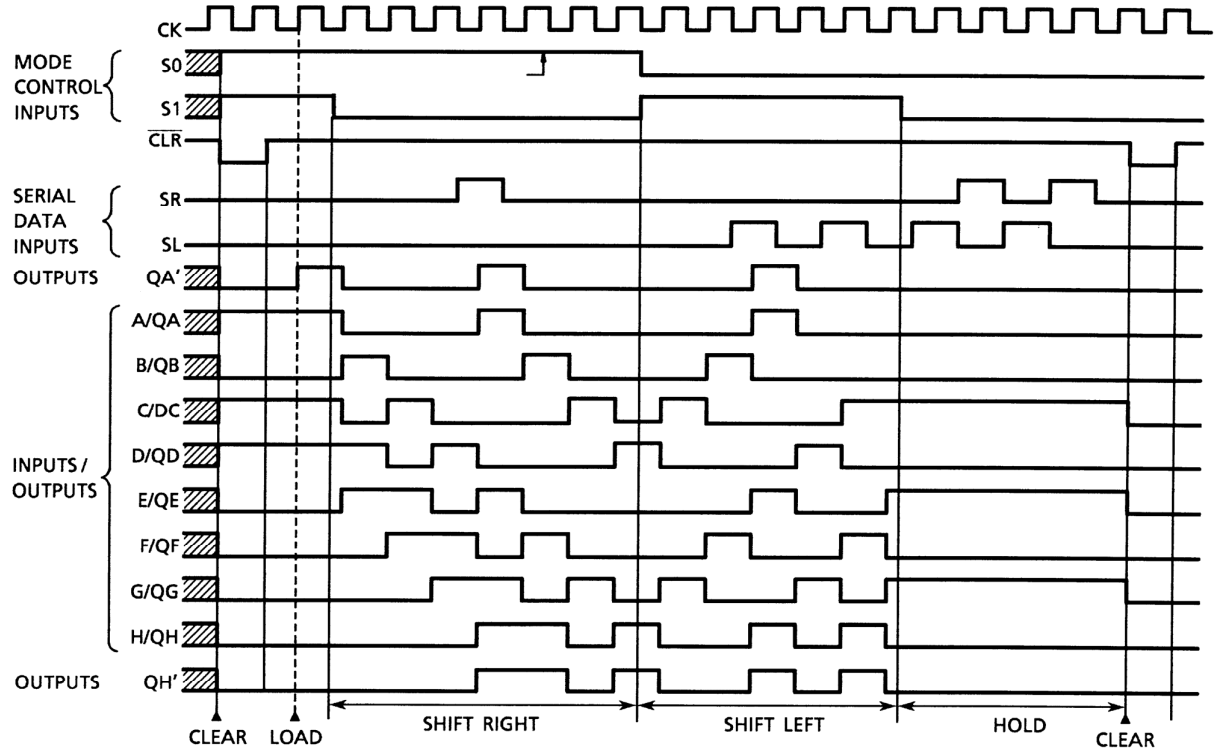
Qn0: The level of Qn before the indicated steady-state input conditions were established.

Qnn: The level of Qn before the most recent active transition indicated by  $\downarrow$  or  $\uparrow$ .

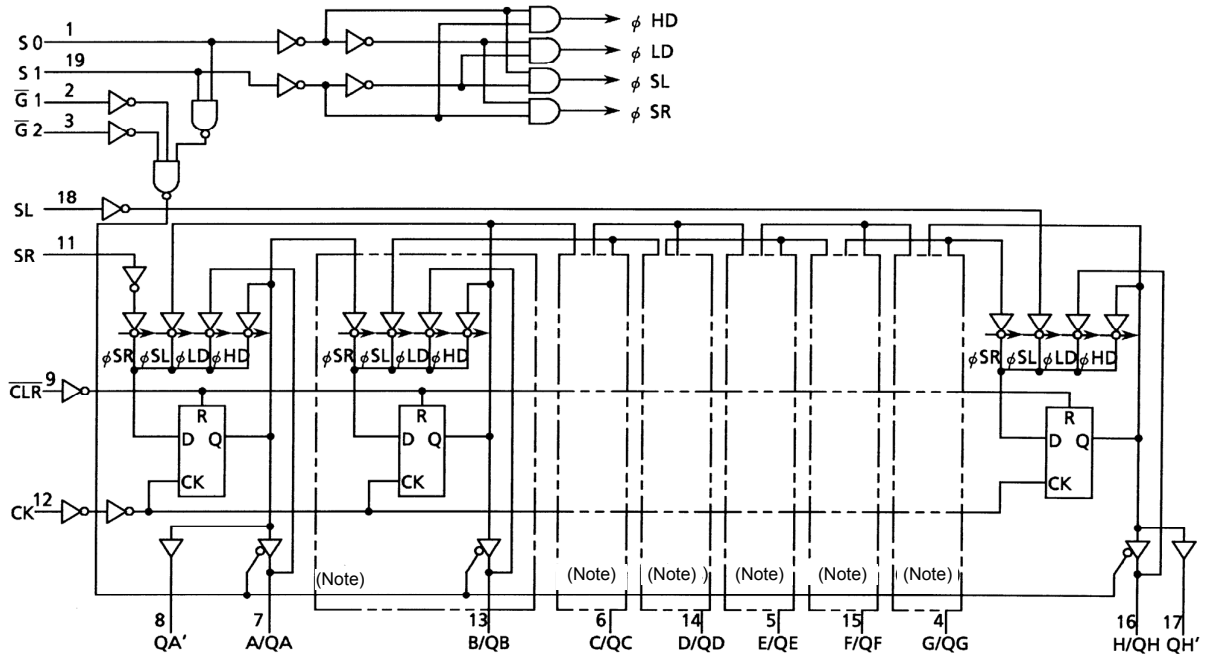
a, h: The level of the steady-state inputs A, H, respectively.

X: Don't care

Timing Chart



System Diagram



Note: Equivalent circuits

## Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Supply voltage range	$V_{CC}$	-0.5 to 7.0	V
DC input voltage	$V_{IN}$	-0.5 to $V_{CC} + 0.5$	V
DC output voltage	$V_{OUT}$	-0.5 to $V_{CC} + 0.5$	V
Input diode current	$I_{IK}$	$\pm 20$	mA
Output diode current	$I_{OK}$	$\pm 50$	mA
DC output current	$I_{OUT}$	$\pm 50$	mA
DC $V_{CC}$ /ground current	$I_{CC}$	$\pm 250$	mA
Power dissipation	$P_D$	500 (DIP) (Note 2)/180 (SOP)	mW
Storage temperature	$T_{stg}$	-65 to 150	$^{\circ}C$

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: 500 mW in the range of  $T_a = -40$  to  $65^{\circ}C$ . From  $T_a = 65$  to  $85^{\circ}C$  a derating factor of  $-10$  mW/ $^{\circ}C$  should be applied up to 300 mW.

## Operating Ranges (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage	$V_{CC}$	2.0 to 5.5	V
Input voltage	$V_{IN}$	0 to $V_{CC}$	V
Output voltage	$V_{OUT}$	0 to $V_{CC}$	V
Operating temperature	$T_{opr}$	-40 to 85	$^{\circ}C$
Input rise and fall time	dt/dV	0 to 100 ( $V_{CC} = 3.3 \pm 0.3$ V) 0 to 20 ( $V_{CC} = 5 \pm 0.5$ V)	ns/V

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

## Electrical Characteristics

### DC Characteristics

Characteristics	Symbol	Test Condition		Ta = 25°C			Ta = -40 to 85°C		Unit	
				V <sub>CC</sub> (V)	Min	Typ.	Max	Min		Max
High-level input voltage	V <sub>IH</sub>	—		2.0	1.50	—	—	1.50	—	V
				3.0	2.10	—	—	2.10	—	
				5.5	3.85	—	—	3.85	—	
Low-level input voltage	V <sub>IL</sub>	—		2.0	—	—	0.50	—	0.50	V
				3.0	—	—	0.90	—	0.90	
				5.5	—	—	1.65	—	1.65	
High-level output voltage	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -50 μA	2.0	1.9	2.0	—	1.9	—	V
				3.0	2.9	3.0	—	2.9	—	
				4.5	4.4	4.5	—	4.4	—	
			I <sub>OH</sub> = -4 mA	3.0	2.58	—	—	2.48	—	
				4.5	3.94	—	—	3.80	—	
I <sub>OH</sub> = -75 mA (Note)	5.5	—	—	—	3.85	—				
Low-level output voltage	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 50 μA	2.0	—	0.0	0.1	—	0.1	V
				3.0	—	0.0	0.1	—	0.1	
				4.5	—	0.0	0.1	—	0.1	
			I <sub>OL</sub> = 12 mA	3.0	—	—	0.36	—	0.44	
				4.5	—	—	0.36	—	0.44	
I <sub>OL</sub> = 75 mA (Note)	5.5	—	—	—	—	1.65				
3-state output off-state current	I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>OUT</sub> = V <sub>CC</sub> or GND		5.5	—	—	±0.5	—	±5.0	μA
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		5.5	—	—	±0.1	—	±1.0	μA
Quiescent supply current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		5.5	—	—	8.0	—	80.0	μA

Note: This spec indicates the capability of driving 50 Ω transmission lines.

One output should be tested at a time for a 10 ms maximum duration.

### Timing Recommended Operating Conditions (input: $t_r = t_f = 3 \text{ ns}$ )

Characteristics	Symbol	Test Condition	Ta = 25°C		Ta = -40 to 85°C		Unit
			V <sub>CC</sub> (V)	Limit	Limit	Limit	
Minimum pulse width (CK)	$t_W$ (L) $t_W$ (H)	—	3.3 ± 0.3	8.0	8.0	ns	
			5.0 ± 0.5	5.0	5.0		
Minimum pulse width ( $\overline{\text{CLR}}$ )	$t_W$ (L)	—	3.3 ± 0.3 5.0 ± 0.5	7.0 5.0	7.0 5.0	ns	
Minimum set-up time (SL, SR, A~H)	$t_s$	—	3.3 ± 0.3	6.0	6.0	ns	
			5.0 ± 0.5	4.0	4.0		
Minimum set-up time (S0, S1)	$t_s$	—	3.3 ± 0.3	11.9	13.6	ns	
			5.0 ± 0.5	7.0	7.0		
Minimum hold time (SL, SR, A~H)	$t_h$	—	3.3 ± 0.3	1.0	1.0	ns	
			5.0 ± 0.5	1.0	1.0		
Minimum hold time (S0, S1)	$t_h$	—	3.3 ± 0.3	0.0	0.0	ns	
			5.0 ± 0.5	0.0	0.0		
Minimum removal time ( $\overline{\text{CLR}}$ )	$t_{\text{rem}}$	—	3.3 ± 0.3	5.0	5.0	ns	
			5.0 ± 0.5	3.0	3.0		

### AC Characteristics (C<sub>L</sub> = 50 pF, R<sub>L</sub> = 500 Ω, input: $t_r = t_f = 3 \text{ ns}$ )

Characteristics	Symbol	Test Condition	Ta = 25°C			Ta = -40 to 85°C		Unit	
			V <sub>CC</sub> (V)	Min	Typ.	Max	Min		Max
Propagation delay time (CK-QA', QH')	$t_{\text{pLH}}$ $t_{\text{pHL}}$	—	3.3 ± 0.3	—	10.6	18.4	1.0	21.0	ns
			5.0 ± 0.5	—	6.8	10.5	1.0	12.0	
Propagation delay time ( $\overline{\text{CLR}}$ -QA', QH')	$t_{\text{pLH}}$ $t_{\text{pHL}}$	—	3.3 ± 0.3	—	8.1	14.0	1.0	16.0	ns
			5.0 ± 0.5	—	6.1	9.2	1.0	10.5	
Propagation delay time (CK-QA~QH)	$t_{\text{pLH}}$ $t_{\text{pHL}}$	—	3.3 ± 0.3	—	10.9	19.3	1.0	22.0	ns
			5.0 ± 0.5	—	7.3	10.5	1.0	12.0	
Propagation delay time ( $\overline{\text{CLR}}$ -QA~QH)	$t_{\text{pLH}}$ $t_{\text{pHL}}$	—	3.3 ± 0.3	—	9.8	16.7	1.0	19.0	ns
			5.0 ± 0.5	—	6.7	10.9	1.0	12.4	
Output enable time	$t_{\text{pZL}}$ $t_{\text{pZH}}$	—	3.3 ± 0.3	—	9.9	17.5	1.0	20.0	ns
			5.0 ± 0.5	—	6.6	9.6	1.0	11.0	
Output disable time	$t_{\text{pLZ}}$ $t_{\text{pHZ}}$	—	3.3 ± 0.3	—	8.1	14.0	1.0	16.0	ns
			5.0 ± 0.5	—	6.4	9.6	1.0	11.0	
Maximum clock frequency	$f_{\text{max}}$	—	3.3 ± 0.3	45	90	—	45	—	MHz
			5.0 ± 0.5	80	140	—	80	—	
Input capacitance	C <sub>IN</sub>	—	—	5	10	—	10	pF	
Bus input capacitance	C <sub>I/O</sub>	—	—	13	—	—	—	pF	
Power dissipation capacitance (Note)	C <sub>PD</sub>	—	—	137	—	—	—	pF	

Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

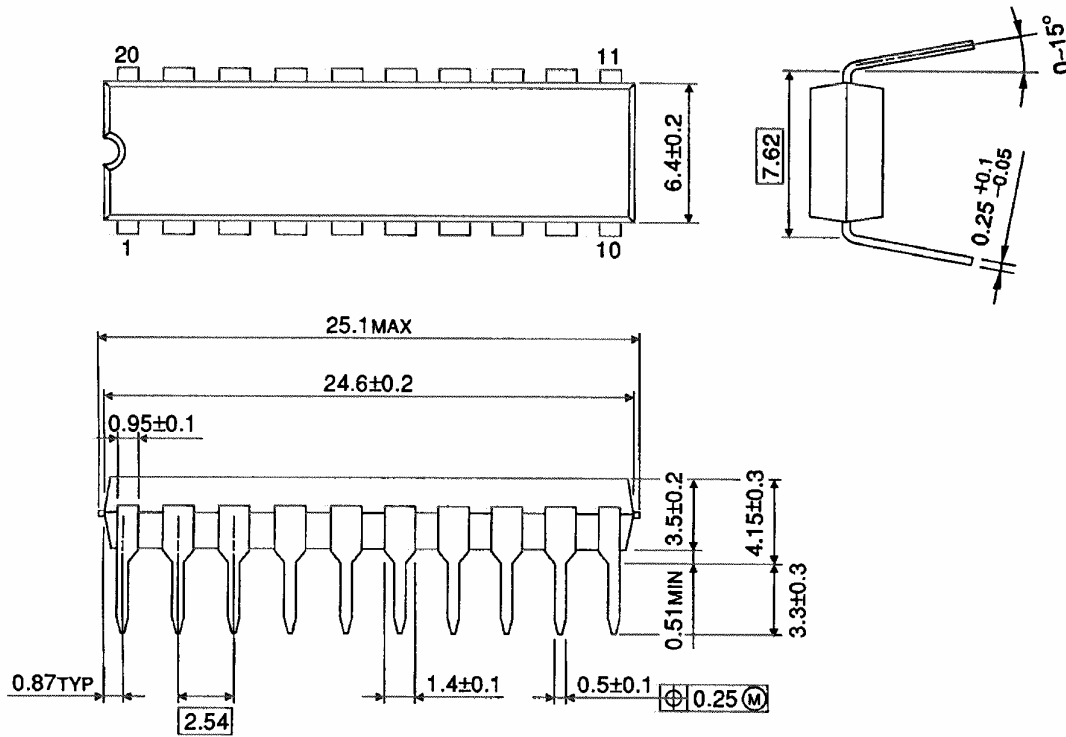
Average operating current can be obtained by the equation:

$$I_{\text{CC (opr)}} = C_{\text{PD}} \cdot V_{\text{CC}} \cdot f_{\text{IN}} + I_{\text{CC}}$$

## Package Dimensions

DIP20-P-300-2.54A

Unit : mm

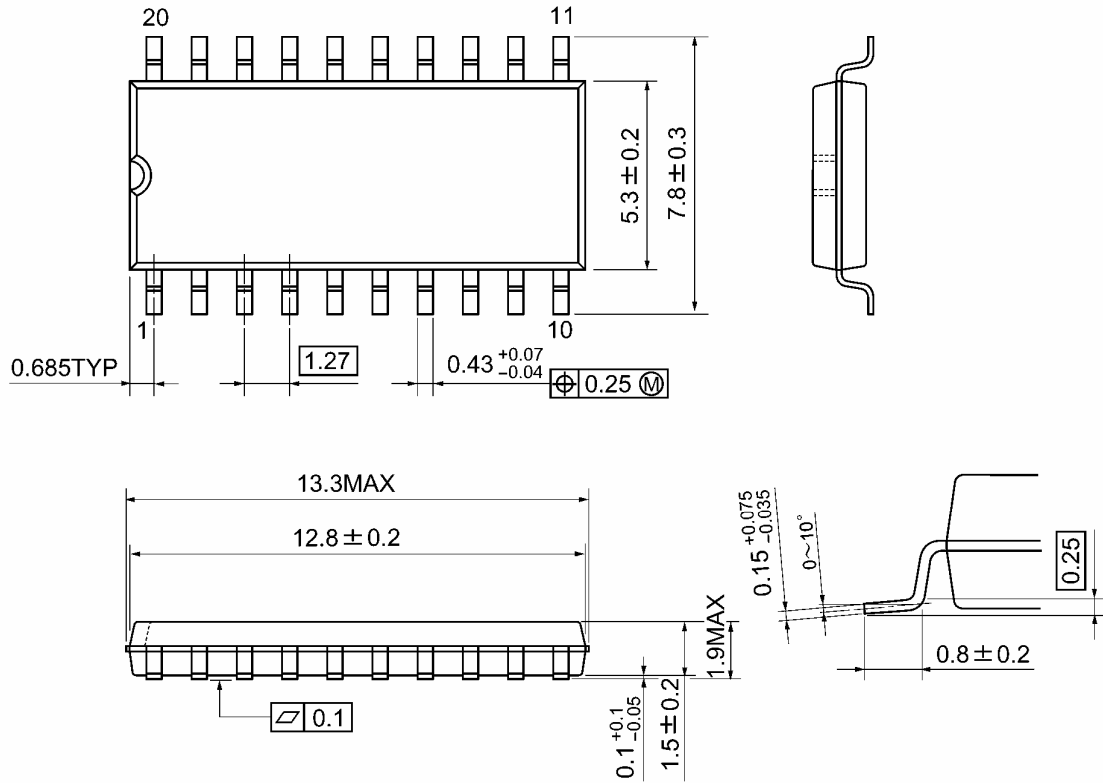


Weight: 1.30 g (typ.)

## Package Dimensions

SOP20-P-300-1.27A

Unit: mm



Weight: 0.22 g (typ.)



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20070701-EN GENERAL

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